Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/030,464	FEUSSNER ET AL.		
Examiner	Art Unit		
Yong D. Pak	1652		

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SEARCHED					
Class	Subclass	Date	Examiner		
435	189	11/28/2005	ΥP		
435	4	11/28/2005	YP		
435	6	11/28/2005	YP		
435	440	11/28/2005	YP		
435	252.3	11/28/2005	YP		
435	320.1	11/28/2005	YP		
435	69.1	11/28/2005	YP		
435	71.1	11/28/2005	YP		
435	25	11/28/2005	YP		
536	23.2	11/28/2005	YP		
536	23.6	11/28/2005	YP		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
stic: seq id no:3	11/28/2005	Ϋ́P		
stn/east: see search history	11/28/2005	YP		
inventor search	11/28/2005	ΥP		
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